

**Search Notes**

Application/Control No.

10/663,901

Examiner

Mai T. Tran

Applicant(s)/Patent under  
Reexamination

KAKUHARI ET AL.

Art Unit

2129

**SEARCHED**

Class	Subclass	Date	Examiner
706	16	3/29/2006	mtt
29	745, 747	3/29/2006	mtt
72	21.4	3/29/2006	mtt
29	861, 857	4/3/2006	mtt
29	844	4/3/2006	mtt
174	1-212 txt	4/4/2006	mtt

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (Please see search history printout)	3/29/2006	mtt
ACM Portal (Please see search history printout)	3/29/2006	mtt
Google (Please see search history printout)	3/29/2006	mtt
IEEE (Please see search history printout)	3/29/2006	mtt
INSPEC	4/4/2006	mtt
Plus Search (Please see search history scanned in eDAN)	3/24/2006	mtt
Consulted with Primary Examiner Anthony D. Tugbang, AU 3729	4/3/2006	mtt
Consulted with Anthony Knight, SPE, AU 2121	4/4/2006	mtt